

UNISONIC TECHNOLOGIES CO., LTD

1N60Q-TA Preliminary Power MOSFET

1.0A, 600V N-CHANNEL POWER MOSFET

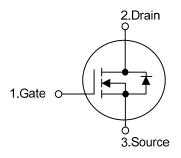
■ DESCRIPTION

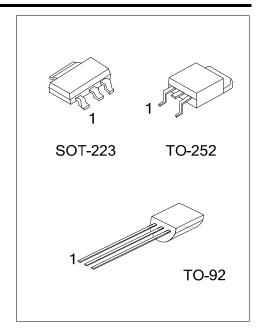
The UTC **1N60Q-TA** is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

- * $R_{DS(ON)} \le 9.0 \Omega @ V_{GS} = 10V, I_D = 0.5A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness



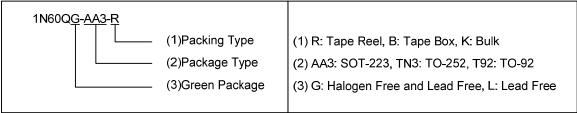




■ ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
1N60QL-AA3-R	1N60QG-AA3-R	SOT-223	G	D	S	Tape Reel	
1N60QL-TN3-R	1N60QG-TN3-R	TO-252	G	D	S	Tape Reel	
1N60QL-T92-B	1N60QG-T92-B	TO-92	G	D	S	Tape Box	
1N60QL-T92-K	1N60QG-T92-K	TO-92	G	D	S	Bulk	

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ MARKING

PACKAGE	MARKING
SOT-223	L: Lead Free G: Halogen Free Lot Code Date Code
TO-252	UTC 1N60Q C: Lead Free G: Halogen Free Date Code
TO-92	UTC 1N60Q□ Code Lot Code UTC 1N60Q□ Code Date Code 1

■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Danie Comment	Continuous (T _C =25°C)	I_{D}	1.0	Α
Continuous Drain Current	Pulsed (Note 2)	I_{DM}	4.0	Α
Avalanche Current (Note 2)	I_{AR}	1	Α
Avalanche Energy	Single Pulsed (Note 2)	E _{AS}	60	mJ
Peak Diode Recovery dv/d	ak Diode Recovery dv/dt (Note 4)		3.5	V/ns
Power Dissipation	SOT-223	P _D	7.8	W
	TO-252		28	W
	TO-92		1.56	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T _{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 120mH, I_{AS} = 1A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 1A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL RESISTANCES CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	SOT-223		150	°C/W	
	TO-252	θ_{JA}	140	°C/W	
	TO-92		110	°C/W	
Junction to Case	SOT-223	$\theta_{ m JC}$	16	°C/W	
	TO-252		4.46	°C/W	
	TO-92		80	°C/W	

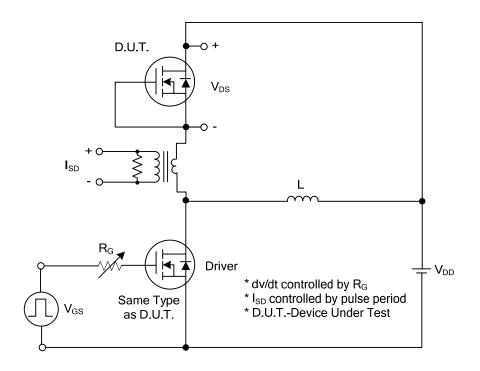
■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	600			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =600V, V _{GS} =0V			10	μA
Coto Source Lookege Current Forward		V _{GS} =30V, V _{DS} =0V			100	nA
Gate-Source Leakage Current Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =0.5A			9.0	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ISS}			195		pF
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V, f=1MHz		20		pF
Reverse Transfer Capacitance	C _{RSS}			3		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A,		13		nC
Gate-Source Charge	Q_GS	$I_{G}=100\mu A$ (Note 1, 2)		1.3		nC
Gate-Drain Charge	Q_GD	IG-100μΑ (Note 1, 2)		1		nC
Turn-On Delay Time (Note 1)	t _{D(ON)}			28		ns
Turn-On Rise Time	t_R	V_{DD} =30V, V_{GS} =10V, I_{D} =0.5A,		19		ns
Turn-Off Delay Time	t _{D(OFF)}	R _G =25Ω(Note 1, 2)		53		ns
Turn-Off Fall Time	t _F			25		ns
SOURCE-DRAIN DIODE RATINGS AND CI	HARACTERIST	ICS				
Maximum Continuous Drain-Source Diode	Is				1	Α
Forward Current	IS				'	А
Maximum Pulsed Drain-Source Diode	la				4	Α
Forward Current	I _{SM}				4	^
Drain-Source Diode Forward Voltage (Note 1	l) V _{SD}	V_{GS} =0 V , I_S =1.0 A			1.4	V
Reverse Recovery Time (Note 1)	t _{rr}	V _{GS} = 0V, I _S = 1.0A,		200		nS
Reverse Recovery Charge	Q _{rr}	$dI_F / dt = 100A/\mu s$ (Note 1)		0.44		μC

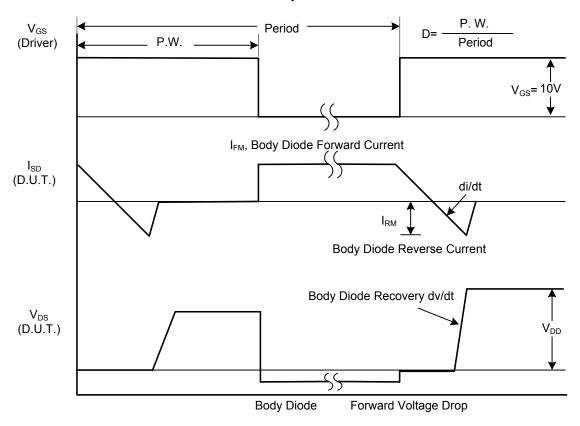
Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

^{2.} Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

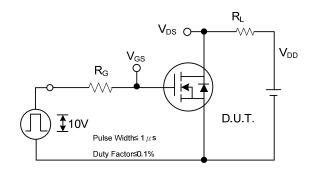


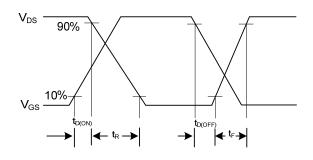
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

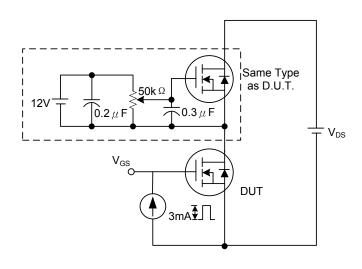
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

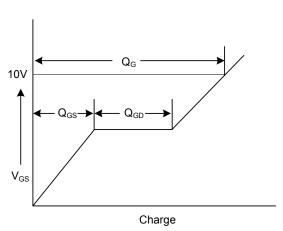




Switching Test Circuit

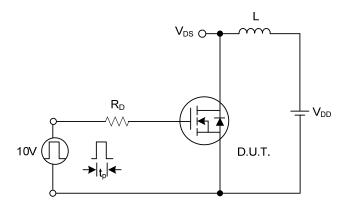
Switching Waveforms

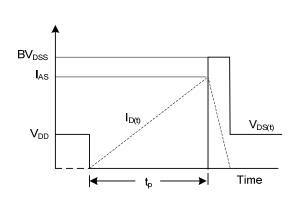




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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